

Search Notes



Application/Control No.

10/663,929

Examiner

Mark K. Han

Applicant(s)/Patent under
Reexamination

LAVI ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	110 131	10/2/2006	<i>mah</i>
	138 139		
	156 181		
	183 186		
	187 191		
	192 194		
	195 196		
	197 199		
	200 205		
	207 211		
	224 232		
	246 264		
	272 518		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	10/2/2006	<i>mah</i>